Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,447	KANEKO, TSUYOSHI	
Examiner	Art Unit	

2828

Phillip Nguyen

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	SEARCHED					
Class	Subclass	Date	Examiner			
372	43.01, 44.01,92, 98-99	6/22/2006	PN			
		-				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
see the se	arch report	7/6/2006	PN		

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST text search (see the printout)	6/22/2006	PN